EE 245: Introduction to MEMS
Module 7: Mechanics of Materials



# EE C245 - ME C218 Introduction to MEMS Design Fall 2009

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Lecture Module 7: Mechanics of Materials

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#### Outline

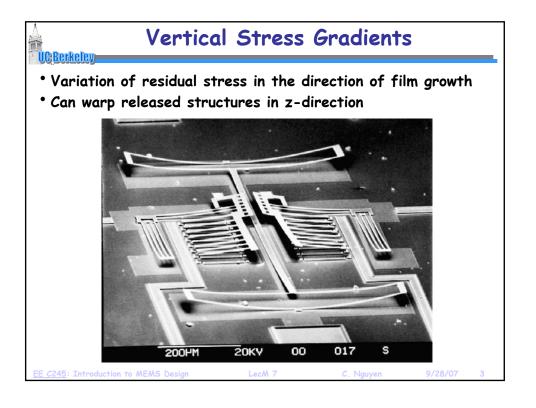
- Reading: Senturia, Chpt. 8
- Lecture Topics:
  - \$Stress, strain, etc., for isotropic materials
  - Thin films: thermal stress, residual stress, and stress gradients
  - ♦ Internal dissipation
  - MEMS material properties and performance metrics

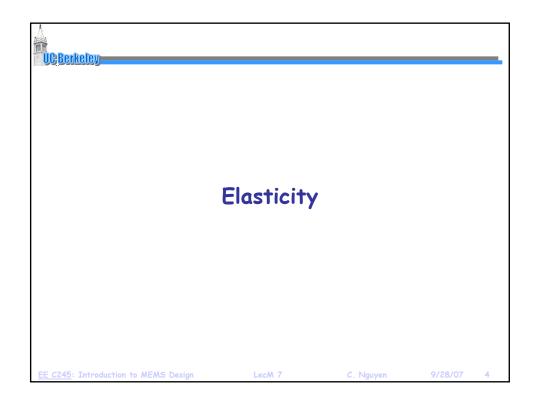
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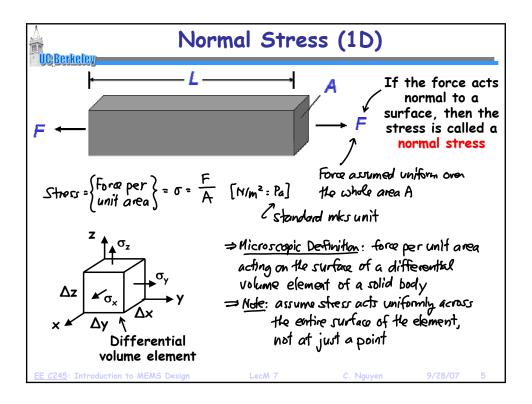
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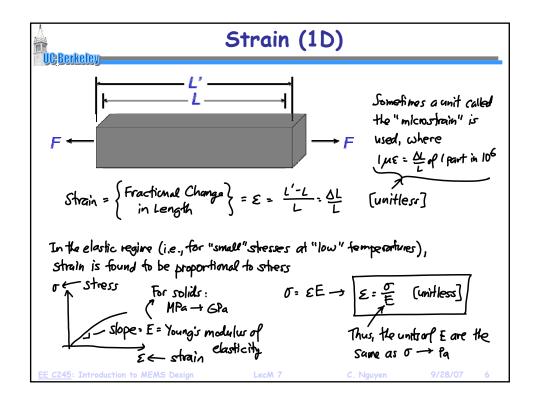
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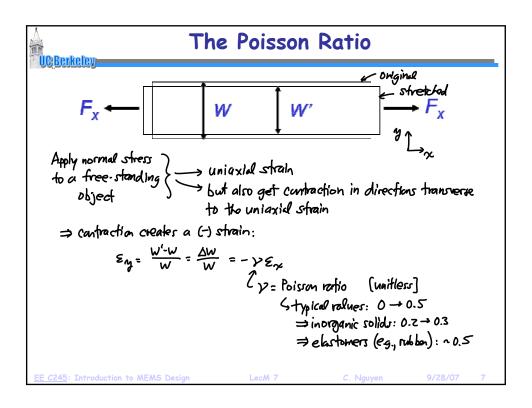
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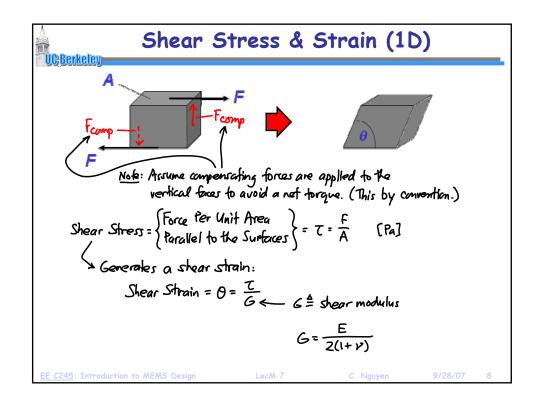


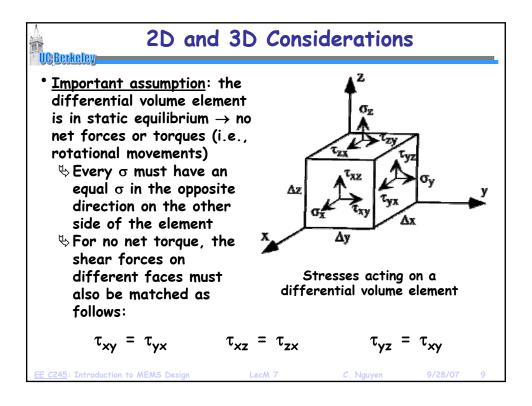


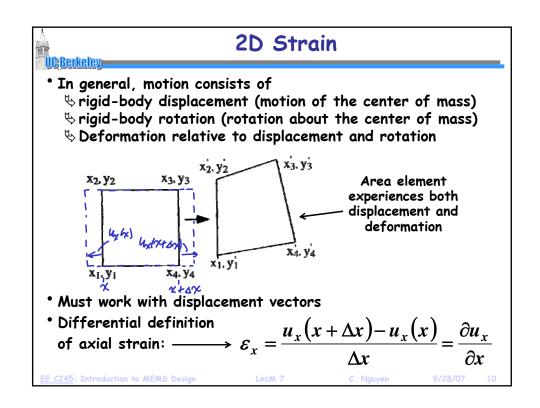


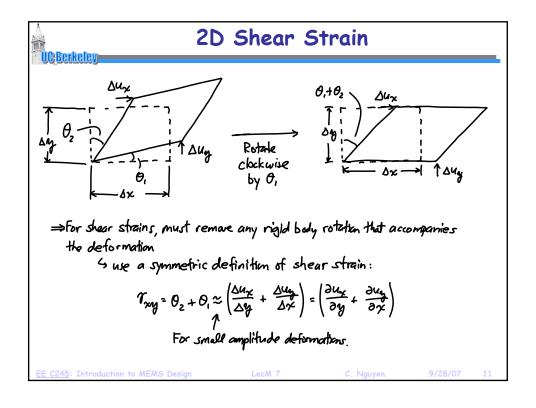


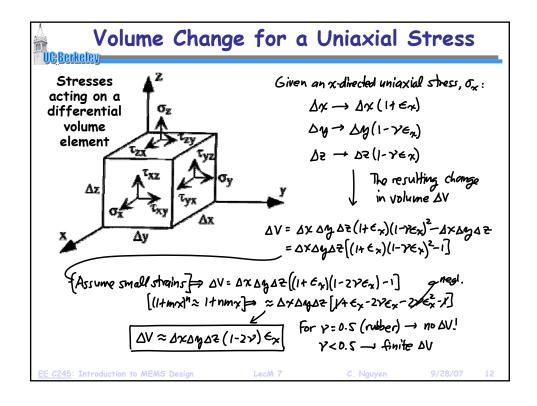












### Isotropic Elasticity in 3D

#### **UC Berkeley**

- Isotropic = same in all directions
- The complete stress-strain relations for an isotropic elastic solid in 3D: (i.e., a generalized Hooke's Law)

$$\varepsilon_x = \frac{1}{E} \left[ \sigma_x - \nu \left( \sigma_y + \sigma_z \right) \right] \qquad \gamma_{xy} = \frac{1}{G} \tau_{xy}$$

$$\varepsilon_{y} = \frac{1}{E} \left[ \sigma_{y} - \nu (\sigma_{z} + \sigma_{x}) \right] \qquad \gamma_{yz} = \frac{1}{G} \tau_{yz}$$

$$\varepsilon_z = \frac{1}{E} \left[ \sigma_z - \nu \left( \sigma_x + \sigma_y \right) \right] \qquad \gamma_{zx} = \frac{1}{G} \tau_{zx}$$

Basically, add in off-axis strains from normal stresses in other directions

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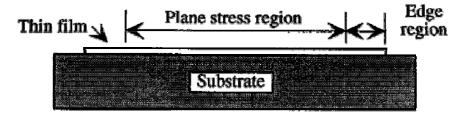
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## Important Case: Plane Stress

 <u>Common case</u>: very thin film coating a thin, relatively rigid substrate (e.g., a silicon wafer)



- \* At regions more than 3 thicknesses from edges, the top surface is stress-free  $\to \sigma_z$  = 0
- Get two components of in-plane stress:

$$\varepsilon_x = (1/E)[\sigma_x - \nu(\sigma_v + 0)]$$

$$\varepsilon_{v} = (1/E)[\sigma_{v} - v(\sigma_{x} + 0)]$$

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### Important Case: Plane Stress (cont.)

- Symmetry in the xy-plane  $\rightarrow \sigma_x = \sigma_y = \sigma$
- \* Thus, the in-plane strain components are:  $\epsilon_{x}$  =  $\epsilon_{y}$  =  $\epsilon$  where

$$\varepsilon_x = (1/E)[\sigma - v\sigma] = \frac{\sigma}{[E/(1-v)]} = \frac{\sigma}{E'}$$

and where

Biaxial Modulus 
$$\stackrel{\triangle}{=} E' = \frac{E}{1-\nu}$$

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Edge Region of a Tensile ( $\sigma$ >0) Film **UCBerkeley** Net non-zero in-At free edge, Film must plane force (that in-plane force be bent we just analyzed) must be zero; back, here Shear stresses There's no Poisson F≠0 contraction, so the film is slightly thicker, here Extra peel force Discontinuity of stress Peel forces that at the attached corner can peel the film → stress concentration off the surface

# Linear Thermal Expansion

- As temperature increases, most solids expand in volume
- Definition: linear thermal expansion coefficient

Linear thermal expansion coefficient 
$$\triangleq \alpha_T = \frac{d\varepsilon_x}{dT}$$
 [Kelvin-1]

#### Remarks:

- \*  $\alpha_{\text{T}}$  values tend to be in the  $10^{\text{-}6}$  to  $10^{\text{-}7}$  range
- $^{\bullet}$  Can capture the  $10^{-6}$  by using dimensions of  $\mu strain/K$  , where  $10^{-6}$   $K^{-1}$  = 1  $\mu strain/K$
- In 3D, get volume thermal expansion coefficient  $\longrightarrow \frac{\Delta V}{V} = 3\alpha_T \Delta T$
- $^{\bullet}$  For moderate temperature excursions,  $a_{\rm T}$  can be treated as a constat of the material, but in actuality, it is a function of temperature

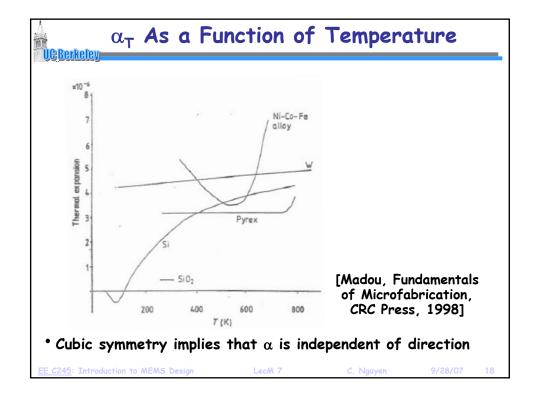
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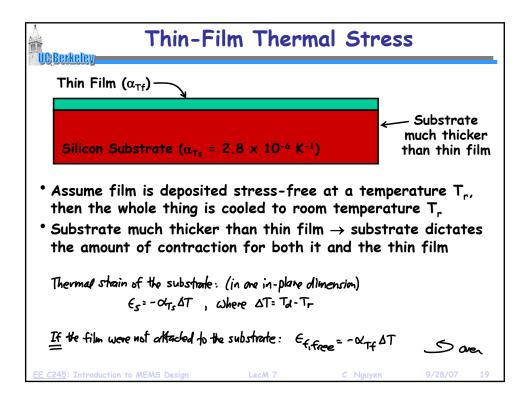
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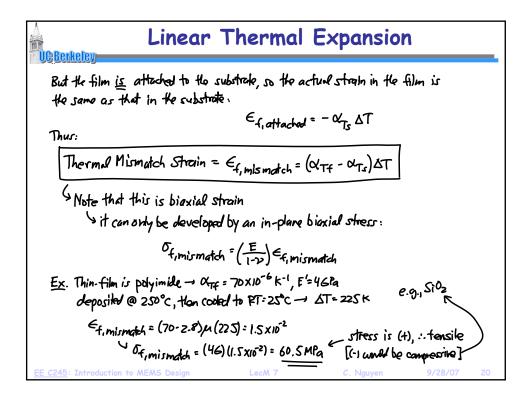
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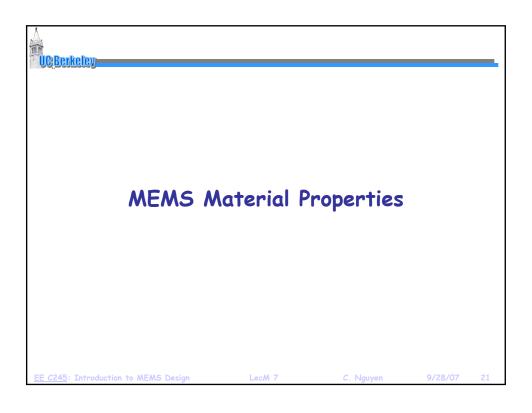
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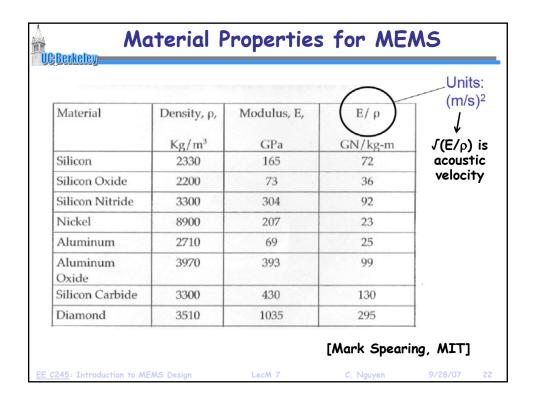
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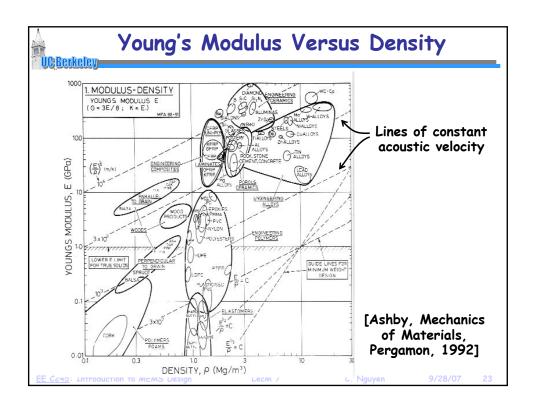


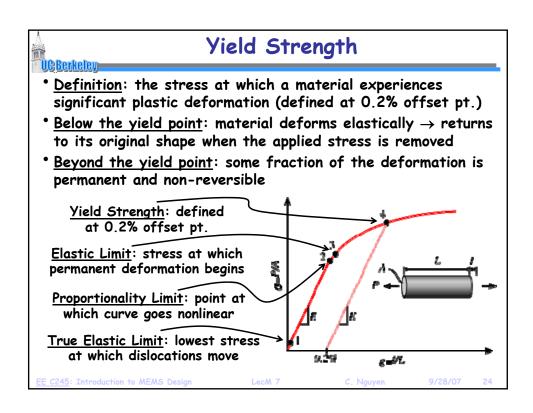


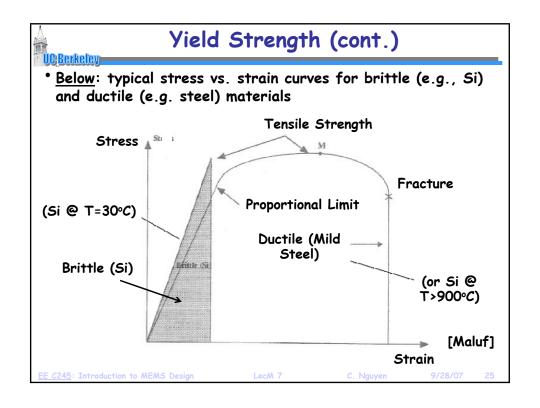




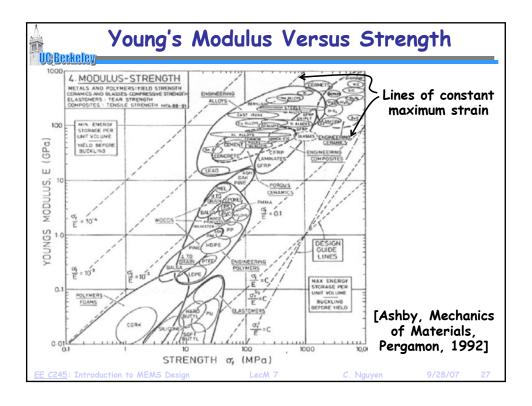


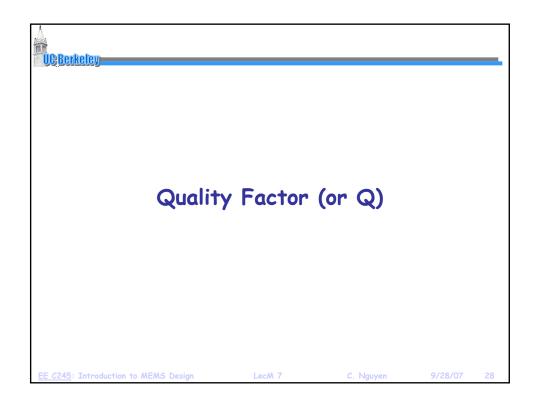


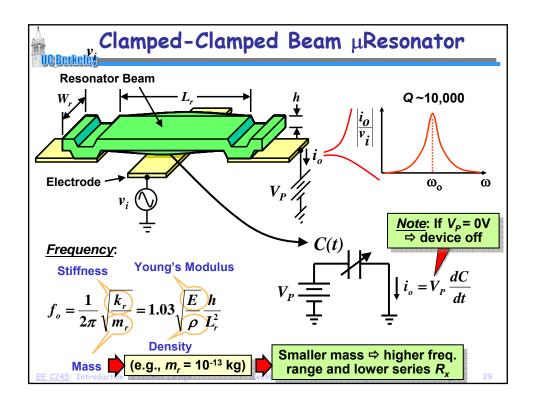


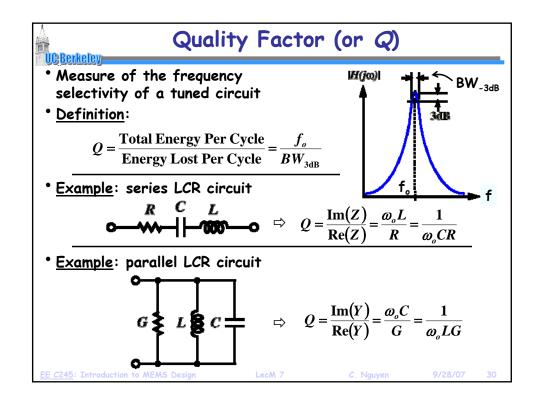


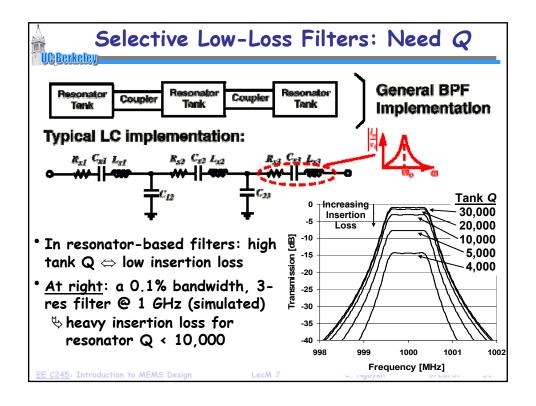
	Stored mech	nanical energy	_	
Material	Modulus, E,	Useful Strength*, σ <sub>f</sub> ,	$\frac{\sigma_f}{E}$	$\left(\begin{array}{c} \sigma_f^2 \\ \overline{E} \end{array}\right)$
	GPa	MPa	(-) x 10 <sup>-3</sup>	MJ/m <sup>3</sup>
Silicon	165	4000	24	97
Silicon Oxide	73	1000	13	14
Silicon Nitride	304	1000	3	4
Nickel	207	500	2	1.2
Aluminum	69	300	4	1.3
Aluminum Oxide	393	2000	5	10
Silicon Carbide	430	2000	4	9.3
Diamond	1035	1000	1	0.9

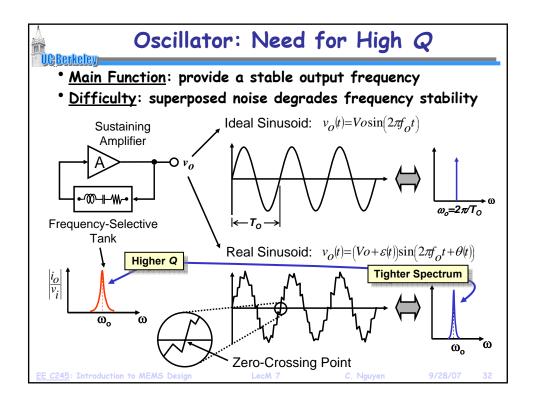


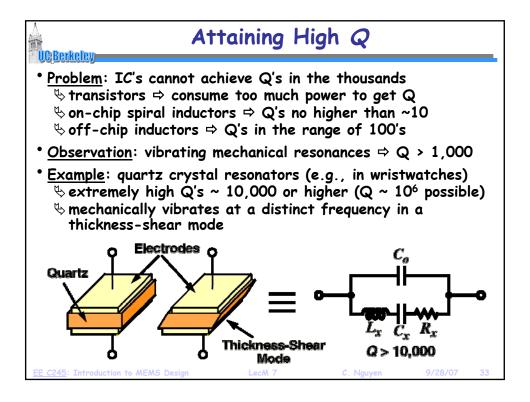


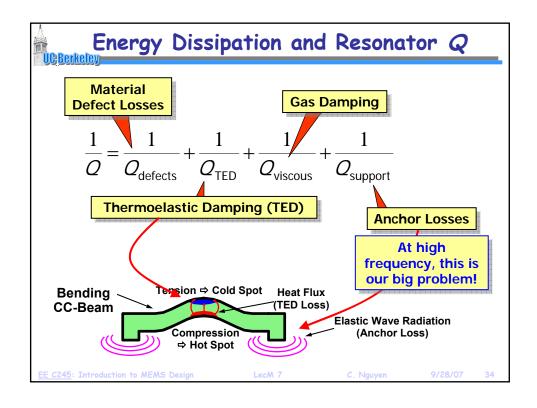


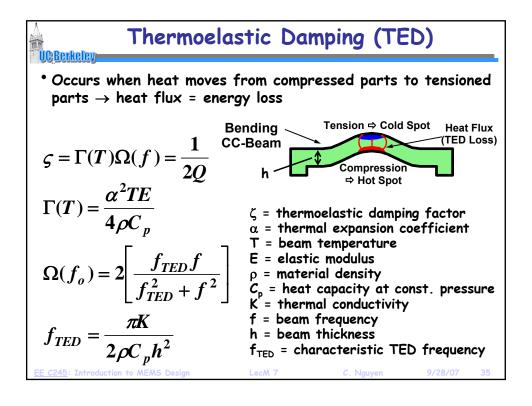


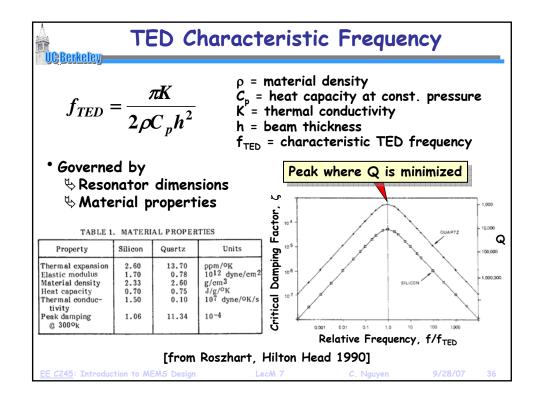


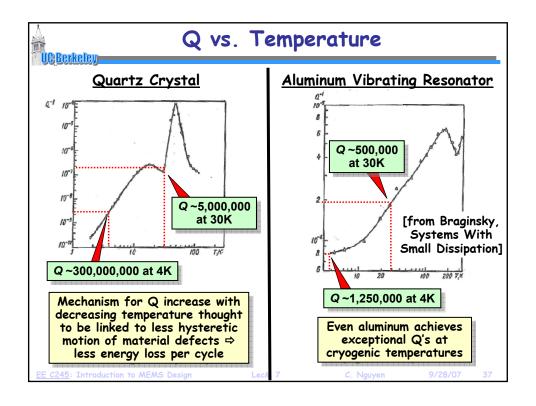


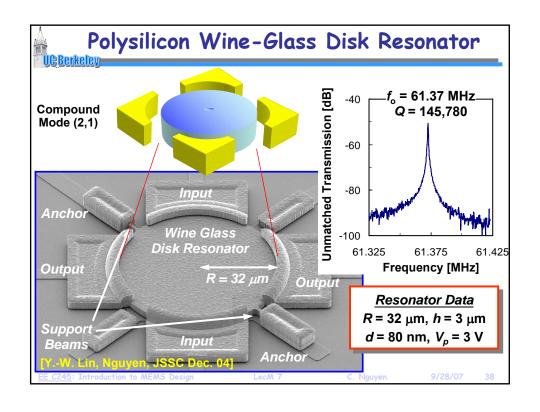


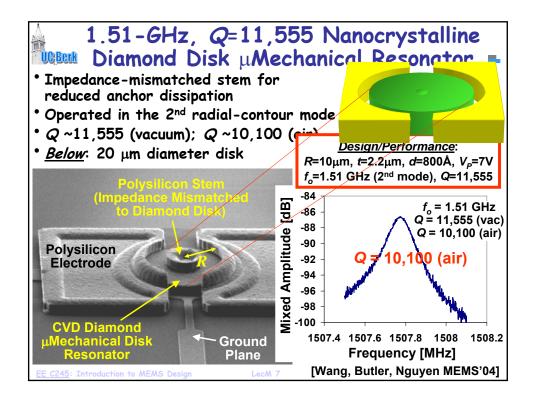


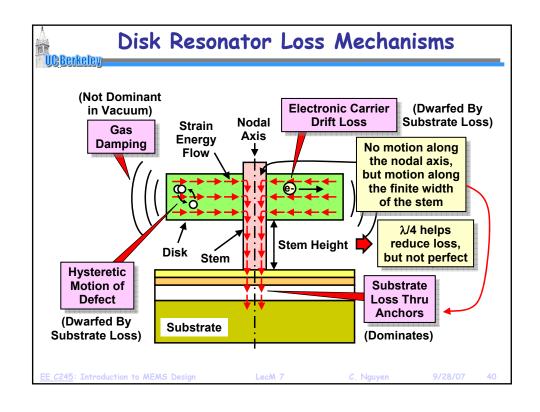


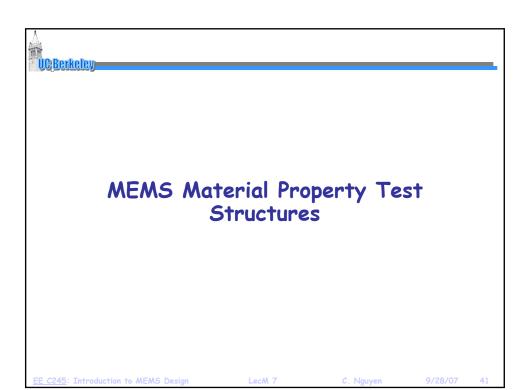


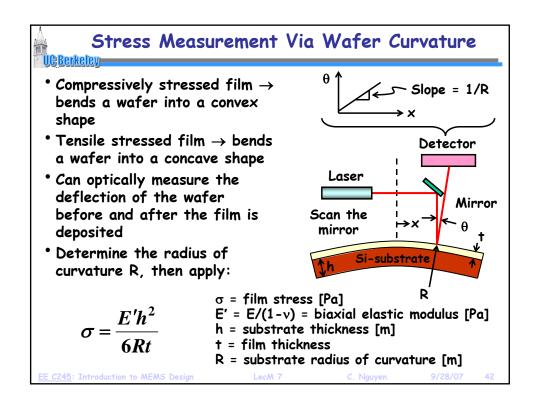


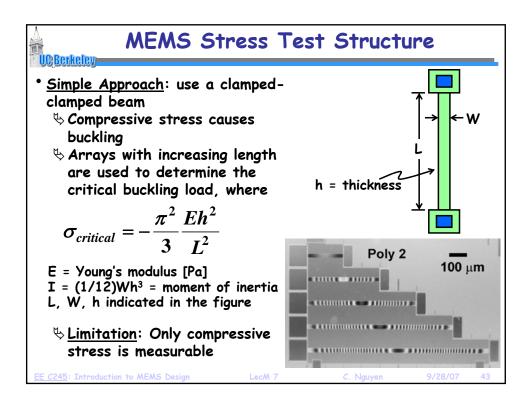


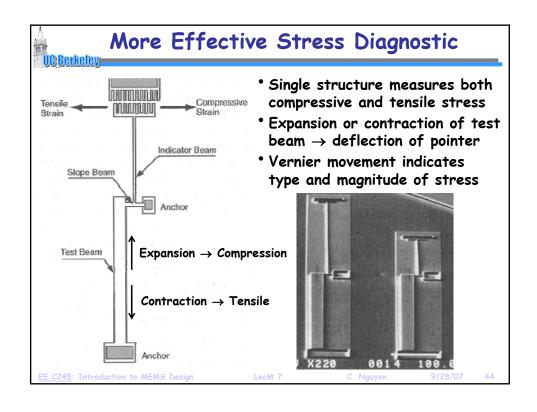


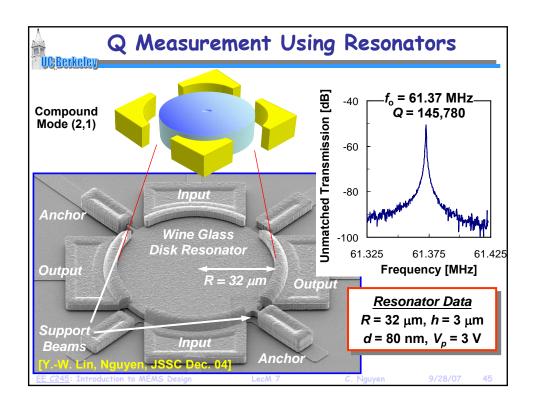


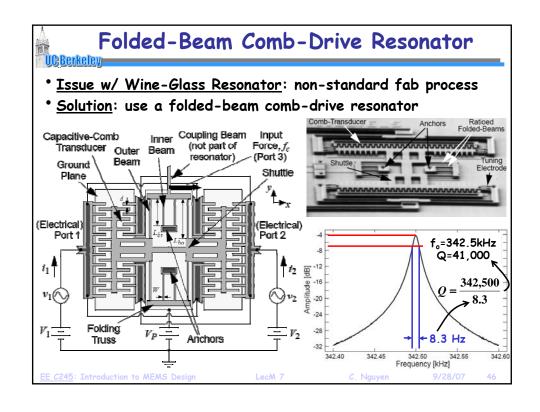


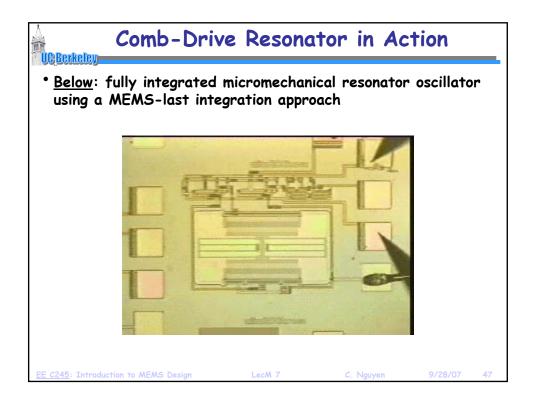


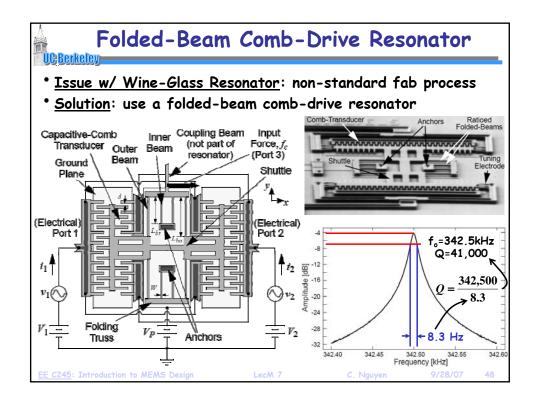




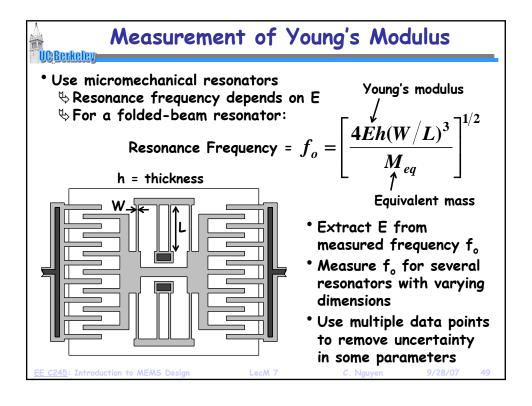


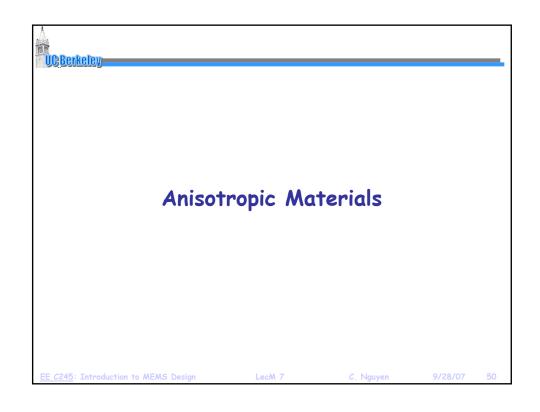






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# Elastic Constants in Crystalline Materials

- \* Get different elastic constants in different crystallographic directions  $\rightarrow$  81 of them in all
  - ♥ Cubic symmetries make 60 of these terms zero, leaving
     21 of them remaining that need be accounted for
- Thus, describe stress-strain relations using a 6x6 matrix

$$\begin{bmatrix} \sigma_x \\ \sigma_y \\ \sigma_z \\ \tau_{yz} \\ \tau_{zx} \\ \tau_{xy} \end{bmatrix} = \begin{bmatrix} C_{11} & C_{12} & C_{13} & C_{14} & C_{15} & C_{16} \\ C_{12} & C_{22} & C_{23} & C_{24} & C_{25} & C_{26} \\ C_{13} & C_{23} & C_{33} & C_{34} & C_{35} & C_{36} \\ C_{14} & C_{24} & C_{34} & C_{44} & C_{45} & C_{46} \\ C_{15} & C_{25} & C_{35} & C_{45} & C_{55} & C_{56} \\ C_{16} & C_{26} & C_{36} & C_{46} & C_{56} & C_{66} \end{bmatrix} \begin{bmatrix} \varepsilon_x \\ \varepsilon_y \\ \varepsilon_z \\ \gamma_{yz} \\ \gamma_{zx} \\ \gamma_{xy} \end{bmatrix}$$
Stresses

Stiffness Coefficients

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Stiffness Coefficients of Silicon

- Due to symmetry, only a few of the 21 coefficients are non-zero
- With cubic symmetry, silicon has only 3 independent components, and its stiffness matrix can be written as:

$$\begin{bmatrix} \sigma_x \\ \sigma_y \\ \sigma_z \\ \tau_{yz} \\ \tau_{zx} \\ \tau_{xy} \end{bmatrix} = \begin{bmatrix} C_{11} & C_{12} & C_{13} & 0 & 0 & 0 \\ C_{12} & C_{22} & C_{23} & 0 & 0 & 0 \\ C_{13} & C_{23} & C_{33} & 0 & 0 & 0 \\ 0 & 0 & 0 & C_{44} & 0 & 0 \\ 0 & 0 & 0 & 0 & C_{55} & 0 \\ 0 & 0 & 0 & 0 & 0 & C_{66} \end{bmatrix} \begin{bmatrix} \varepsilon_x \\ \varepsilon_y \\ \varepsilon_z \\ \gamma_{yz} \\ \gamma_{zx} \\ \gamma_{xy} \end{bmatrix}$$

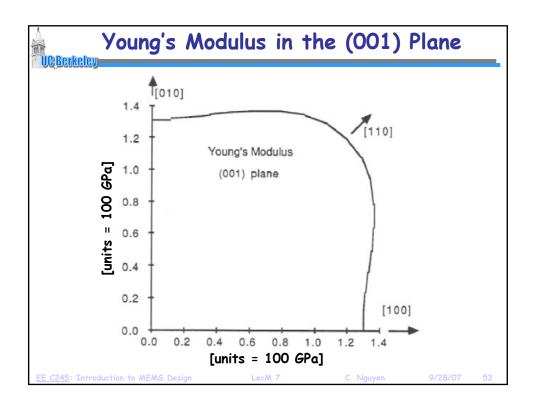
where 
$$\left\{ \begin{array}{l} \textit{C}_{11} = 165.7 \; \textit{GPa} \\ \textit{C}_{12} = 63.9 \; \textit{GPa} \\ \textit{C}_{44} = 79.6 \; \textit{GPa} \end{array} \right.$$

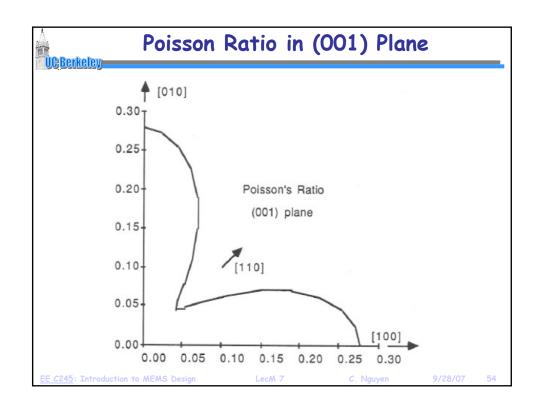
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#### Anisotropic Design Implications UC Berkeley Young's modulus and Poisson ratio variations in anisotropic materials can pose problems in the design of certain structures • E.g., disk or ring resonators, which rely on isotropic properties in the radial directions Wine-Glass ♦ Okay to ignore variation in RF Mode Disk resonators, although some Q hit is probably being taken E.g., ring vibratory rate gyroscopes ♦ Mode matching is required, where frequencies along different axes of a ring must be the same Not okay to ignore anisotropic variations, here Ring Gyroscope